

WFU4N60

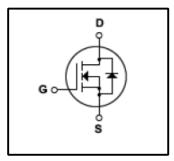
Silicon N-Channel MOSFET

Features

- 4A,600V.R_{DS(on)}(Max 2.5Ω)@V_{GS}=10V
- Ultra-low Gate Charge(Typical 16nC)
- Fast Switching Capability
- 100%Avalanche Tested
- Isolation Voltage (VISO = 4000V AC)
- Maximum Junction Temperature Range(150°C)

General Description

This Power MOSFET is produced using Winsemi's advanced planar stripe, DMOS technology. This latest technology has been Especially designed to minimize on-state resistance, have a high Rugged avalanche characteristics. This devices is specially well Suited for half bridge and full bridge resonant topology line a Electronic lamp ballast.





Symbol	Parameter	Value	Units
VDSS	Drain Source Voltage	600	V
1-	Continuous Drain Current(@Tc=25℃)	4	A
lo	Continuous Drain Current(@Tc=100℃)		А
Ідм	Drain Current Pulsed (Note1	16	A
Vgs	Gate to Source Voltage	±30	V
Eas	Single Pulsed Avalanche Energy (Note 2)	240	mJ
Ear	Repetitive Avalanche Energy (Note 1) 10	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3	4.5	V/ns
_	Total Power Dissipation(@Tc=25°C)	80	w
PD	Derating Factor above 25°C	0.78	W/℃
TJ, Tstg	Junction and Storage Temperature	-55~150	°C
T∟	Channel Temperature	300	°C

Absolute Maximum Ratings

Thermal Characteristics

Symbol	Parameter		Value	Lipito	
Symbol	Parameter	Min	Тур	Max	Units
Rajc	Thermal Resistance, Junction-to-Case	-	-	1.56	°C/W
Rqja	Thermal Resistance, Junction-to-Ambient*			50	°C/W
Rqja	Thermal Resistance, Junction-to-Ambient	-	-	110	°C/W

*When mounted on the minimum pad size recommended(PCB Mount)



Characteristics		Symbol	Test Condition	Min	Туре	Max	Unit
Gate leakage current		lgss	Vgs = \pm 30 V, Vds = 0 V	-	-	±100	nA
Gate-source bre	akdown voltage	V _{(BR)GSS}	Ig = ±10 μA, V _{DS} = 0 V	±30	-	\	
Drain cut-off current		V _{DS} = 600 V, V _{GS} = 0 V		-	-	10	μA
		IDSS	V _{DS} = 480 V, T _c = 125°C	-	-	100	μΑ
Drain-source bre	eakdown voltage	V(BR)DSS	ID = 250 μA, VGs = 0 V	600	-	-	V
Gate threshold v	e threshold voltage		V _{DS} = 10 V, I _D =250 μA	2	-	4	V
Drain-source ON	I resistance	RDS(ON)	Vgs = 10 V, Id =3.25A	-	1.8	2.5	Ω
Input capacitance		Ciss	V _{DS} = 25 V,	-	545	670	
Reverse transfer capacitance		Crss	Vgs = 0 V,	-	7	10	pF
Output capacitance		Coss	f = 1 MHz	-	70	90	
	Rise time	tr	Vdd =300 V,	-	10	30	
Quaitada in ar tima a	Turn-on time	ton	ID = 4.4 A	-	35	80	
Switching time	Fall time	tf	Rg=25 Ω	-	45	100	ns
	Turn-off time	toff	(Note4,5)	-	20	50	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} = 480 V, V _{GS} = 10 V,	-	16	20	_
Gate-source charge		Qgs	ID =4.4A	-	3.4	-	nC
Gate-drain ("miller") Charge		Qgd	(Note4,5)	-	7	-	

Electrical Characteristics (Tc = 25° C)

Source–Drain Ratings and Characteristics (Ta = 25° C)

Characteristics	Symbol	Test Condition	Min	Туре	Max	Unit
Continuous drain reverse current	ldr	-	-	-	4	А
Pulse drain reverse current	IDRP	-	-	-	17.6	А
Forward voltage (diode)	VDSF	Idr =4.4 A, Vgs = 0 V	-	-	1.4	V
Reverse recovery time	trr	IDR = 4.4 A, VGS = 0 V,	-	390	-	ns
Reverse recovery charge	Qrr	dI _{DR} / dt = 100 Α / μs	-	2.2	-	μC

Note 1.Repeativity rating :pulse width limited by junction temperature

2.L=18.5mH,I_{AS}=4.4A,V_{DD}=50V,R_G=0\Omega,Starting T_J=25\,^\circ\!\!\mathrm{C}

3.I_{SD}≤4A,di/dt≤200A/us, V_{DD}<BV_{DSS},STARTING T_J=25 °C

4.Pulse Test: Pulse Width≤300us,Duty Cycle≤2%

5.Essentially independent of operating temperature.

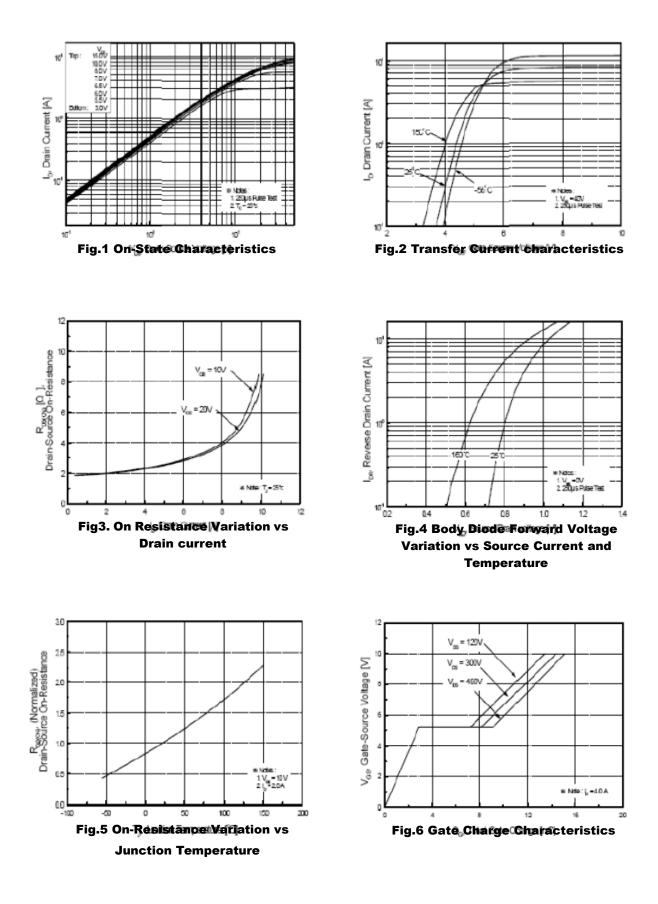
This transistor is an electrostatic sensitive device

Please handle with caution

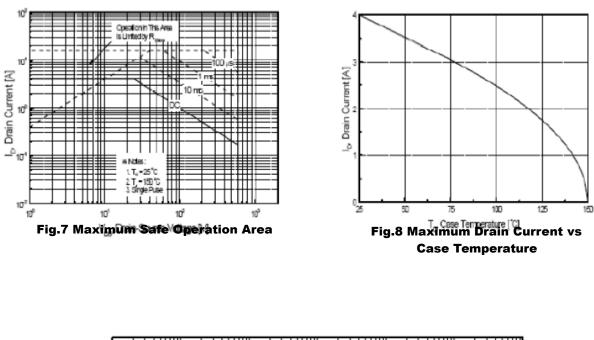




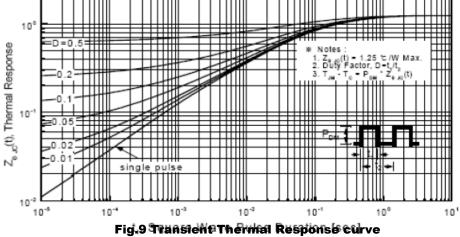
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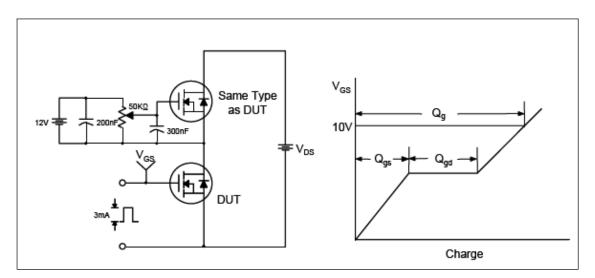


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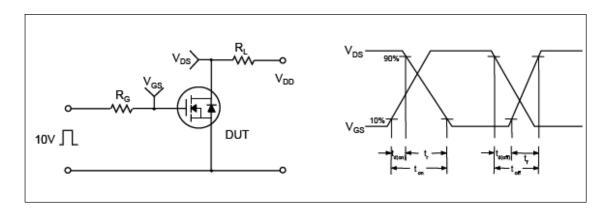


Fig.11 Resistive Switching Test Circuit & Waveform

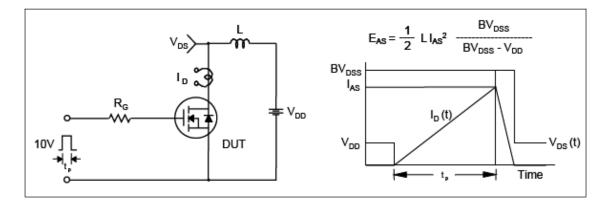


Fig.12 Unclamped Inductive Switching Test Circuit & Waveform



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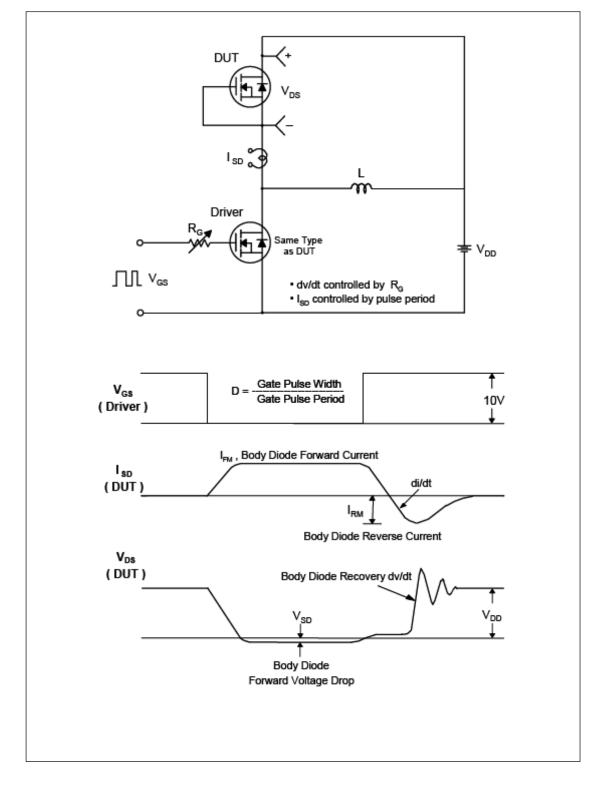
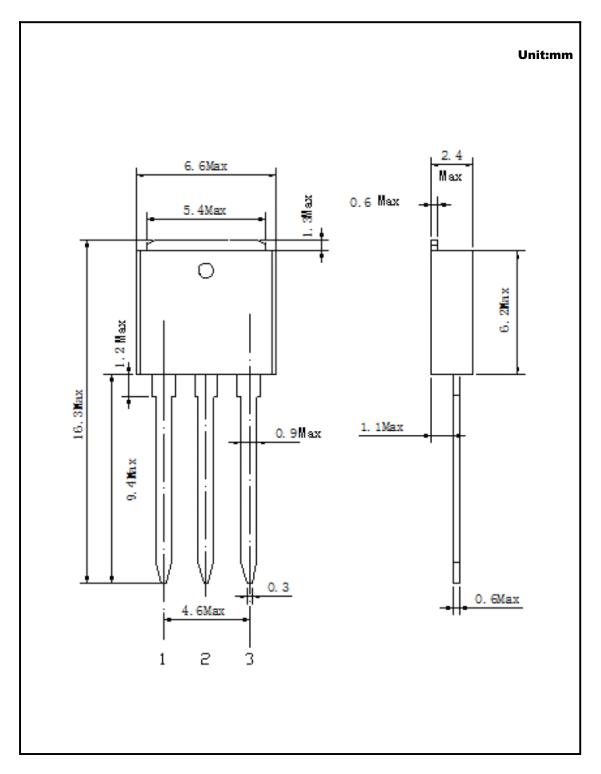


Fig.13 Peak Diode Recovery dv/dt Test Circuit & Waveform



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TO-251 Package Dimension



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